## Electronic Supplementary Information


#### Abstract

Nitrogen doped graphene anchored with mixed growth patterns of CuPt alloy nanoparticles as a highly efficient and durable electrocatalyst for oxygen reduction reaction in alkaline medium


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Fig. S1. FESEM images of CuPt-TBTC/NGr-90.


Fig. S2. FESEM elemental mapping images of CuPt-TBTC/NGr-90: (a) platinum, (b) copper, (c) carbon, (d) nitrogen, (e) oxygen and (f) combined.


Fig. S3. SEM-EDX analysis: a) CuPt-TBTC/NGr-30, b) CuPt-TBTC/NGr-60, c) CuPt-TBTC/NGr-90 and d) CuPt-TBTC/NGr-120.

Table S1. Comparison of the elemental composition of the samples synthesized at different time interval using SEM-EDX analysis.

| Sample | Atomic \% (Cu) | Atomic \% (Pt) | Pt/Cu ratio |
| :---: | :---: | :---: | :---: |
| CuPt-TBTC/NGr-30 | 32.90 | 67.10 | 2.04 |
| CuPt-TBTC/NGr-60 | 27.53 | 72.47 | 2.63 |
| CuPt-TBTC/NGr-90 | 28.98 | 71.02 | 2.45 |
| CuPt-TBTC/NGr-120 | 29.62 | 70.38 | 2.38 |

Table S2. Comparison of the elemental composition of the samples synthesized at different time interval using ICP analysis.

| Sample | Pt/Cu ratio |
| :---: | :---: |
| CuPt-TBTC/NGr-30 | 3.04 |
| CuPt-TBTC/NGr-60 | 3.28 |
| CuPt-TBTC/NGr-90 | 2.91 |
| CuPt-TBTC/NGr-120 | 2.95 |



Fig. S4. TEM images of CuPt-TBTC/NGr-30 recorded at different magnifications: (a) image indicating the mixed dispersion of the tetrapod and disordered CuPt alloy particles on the surface of NGr, (b) higher magnification image of the disordered CuPt alloy particles, (c) magnified view of the tetrapod structures of the CuPt-alloy marked in the red square in (a) with the SAED pattern in the inset and the red arrows indicating the NGr support, and (d) higher magnification image of the disordered CuPt alloy particles marked in the green square in (b) with the inset showing the line profile of the CuPt alloy.


Fig. S5. TEM images of CuPt-TBTC/NGr-60 recorded at different magnifications: (a) image indicating the mixed dispersion of the partially formed trigonal bipyramidal and truncated cubes on the surface of NGr, (b) higher magnification image of the marked (red) portion of (a) and the red arrows indicating the NGr support, (c) magnified image of the partially formed trigonal bipyramidal of the CuPt-alloy, and (d) magnified view of the region marked in the green square in (c) with the inset showing the line profile of the CuPt alloy.


Fig. S6. TEM images of CuPt-TBTC/NGr-120 recorded at different magnifications: (a) image indicating the agglomeration of the trigonal bipyramidal and truncated cubes on the surface of NGr, (b) higher magnification image of the agglomerated trigonal bipyramidal, (c) higher magnification image of the marked (red) portion of (b) with the SAED pattern in the inset, and (d) magnified view of the
agglomerated trigonal bipyramidal marked in the green square in (c) with the inset showing the line profile of the CuPt alloy.


Fig. S7. TEM images of CuPt/NGr-90 without KI addition at different magnifications: (a) image indicating the spherical particles on the surface of NGr, (b) higher magnification image of the marked (red) portion of (a), (c) magnified image of the spherical nanoparticle on NGr, and (d) magnified view of the spherical nanoparticle marked in the green square in (c) with the inset showing the SAED pattern.


Fig. S8. TEM images of CuPt/NGr-90 without PVP addition at different magnifications: (a) image indicating the agglomerated particles without proper geometry on the surface of NGr, (b) higher
magnification image of the marked (red) portion of (a), (c) and (d) higher magnified image of the agglomerated particle on NGr.


Fig. S9. Comparative XRD patterns of CuPt/NGr-xx (where xx stands for 30, 60, 90 and 120 minutes of the reaction time intervals) recorded at different reaction time intervals.


Fig. S10. Comparative Raman data of NGr and CuPt-TBTC/NGr-90.


Fig. S11. TGA profile comparison of CuPt-TBTC/NGr-60, CuPt-TBTC/NGr-90 and CuPt-TBTC/NGr-120 with commercial Pt/C in air atmosphere.


Fig. S12. (a) XPS survey spectra of CuPt-TBTC/NGr-90, deconvoluted XPS profiles of (b) carbon, (c) nitrogen and (d) oxygen in CuPt-TBTC/NGr-90.

The presence of Si peak in the XPS survey scan spectrum of CuPt-TBTC/NGr-90 is due to the sample was coated on the Si substrate during the analysis. The presence of oxygen in the survey scan mainly because of the adsorbed oxygen and residual moisture present in the system.

## Calculation of Electrochemical Active Surface Area (ECSA)

The ECSA value has been obtained by running the CV in $\mathrm{N}_{2}$ saturated atmosphere and calculated by using the below equation;

$$
\operatorname{ECSA}\left(\mathrm{m}^{2} \mathrm{~g}_{\mathrm{pt}}{ }^{-1}\right)=\mathrm{Q}_{\mathrm{H} \text {-desorption }} /\left\{0.21 * \mathrm{Pt}_{\text {loading }}\right\}
$$

where, $\mathrm{Q}_{\mathrm{H} \text {-desorption }}$ is the charge associated with the hydrogen desorption in $\mathrm{mC}, 0.21$ is the constant charge required to remove the monolayer of adsorbed hydrogen layer and the its unit is $\mathrm{mC} \mathrm{cm}{ }^{-2}$, Pt loading for $\mathrm{CuPt}-\mathrm{TBTC} / \mathrm{NGr}-90$ was 0.014 mg and for $\mathrm{Pt} / \mathrm{C}$ was 0.02 mg , respectively.

## Koutecky-Levich (K-L) equation

The kinetic parameters have been obtained by using the Koutecky-Levich (K-L) equation and it can be represented as;

$$
\begin{aligned}
& 1 / \mathrm{j}=1 / \mathrm{j} \stackrel{1}{ }+1 / \mathrm{j}_{\mathrm{K}} \\
& 1 / J=B \omega^{1 / 2}+1 / j_{k} \\
& \text { where, } \mathrm{B}=0.62 \mathrm{n} \mathrm{~F} \mathrm{~A} \mathrm{C}{ }_{0}{ }^{*} \mathrm{D}_{0}{ }^{2 / 3} \mathrm{v}^{-1 / 6} \\
& \text { and } \mathrm{j}_{\mathrm{k}}=\mathrm{nFAKC}{ }_{0}{ }^{*}
\end{aligned}
$$

where, ' j ' is the measured current density, ' $\mathrm{j}_{\mathrm{L}}$ ' is the limiting current density, ' $\mathrm{j}_{\mathrm{k}}$ ' is the kinetic current density, ' $\omega$ ' is the angular rotation ( $\omega=2 \pi \mathrm{f} / 60$, f is the rotation speed), ' n ' is the number of transferred electrons during ORR, ' F ' is the Faraday constant ( 96480 C ), ' $\mathrm{C}_{0}{ }^{* \prime}$ ' is the bulk concentration of $\mathrm{O}_{2}\left(1.22 \times 10^{-6} \mathrm{~mol} \mathrm{~cm}^{-3}\right),{ }^{‘} \mathrm{D}_{0}$ ' is the diffusion coefficient of $\mathrm{O}_{2}(1.9 \mathrm{x}$ $\left.10-5 \mathrm{~cm}^{2} \mathrm{~s}^{-1}\right)$, ' $v$ ' represents the kinematic viscosity of the electrolyte $\left(0.01 \mathrm{~cm}^{2} \mathrm{~s}^{-1}\right)$ and ' k ' is the electron transfer rate constant.

The Rotating Ring Disc Electrode (RRDE) technique was used to calculate the number of electron transferred during the ORR process and also to evaluate the $\mathrm{H}_{2} \mathrm{O}_{2}$ percentage. The
glassy carbon disc $\left(0.2826 \mathrm{~cm}^{2}\right)$ having a Pt ring was used as the working electrode by keeping the ring potential at $0.6 \mathrm{~V}, \mathrm{Hg} / \mathrm{HgO}$ was used as the reference electrode and a graphite rod was used as the counter electrode. The analysis has been done in the $\mathrm{O}_{2}$-saturated 0.1 M KOH solution. Using the below equation, the number of electron transfer during ORR was calculated:

4 Id
$n=$------

$$
I d+I r / N
$$

The $\mathrm{H}_{2} \mathrm{O}_{2}$ percentage was calculated by applying the formula,

$$
200 * \operatorname{Ir} / N
$$

H2O2\% =------

$$
I d+\operatorname{Ir} / N
$$

where, ' $I_{r}$ ' is the Faradaic ring current, ' $I_{d}$ ' is the Faradaic disc current, ' N ' is the collection efficiency (0.37) and ' $n$ ' is the number of transferred electrons.

## Calibration of the reference electrode

In order to convert the potential from $\mathrm{Hg} / \mathrm{HgO}$ to RHE, LSV at a scan rate of $1.0 \mathrm{mV} / \mathrm{s}$ was carried out in 0.1 M KOH solution with saturated hydrogen. Pt was used as the working electrode, Pt wire was as used as the counter electrode and $\mathrm{Hg} / \mathrm{HgO}$ was used as the reference electrode. The correction factor was chosen as the point at which the current crosses the zero line.

So, $\mathrm{E}(\mathrm{RHE})=\mathrm{E}(\mathrm{Hg} / \mathrm{HgO})+0.870$


Fig. S13. Calibration curve for the $\mathrm{Hg} / \mathrm{HgO}$ reference electrode.


Fig. S14. (a) Comparative CV profiles recorded at a scan rate of $50 \mathrm{mV} \mathrm{sec}^{-1}$ in $\mathrm{O}_{2}$ saturated 0.1 M KOH and (b) linear sweep voltammogram comparison of CuPt-TBTC/NGr-60, CuPt-TBTC/NGr-90 and CuPt-TBTC/NGr-120 with 40 wt. \% Pt/C.


Fig. S15. Comparison of the RRDE voltammograms of CuPt-TBTC/NGr-90 and 40 wt. \% Pt/C.


Fig. S16. Linear sweep voltammograms of $40 \mathrm{wt} . \% \mathrm{Pt} / \mathrm{C}$ before and after the durability study.


Fig. S17. TEM images of CuPt-TBTC/NGr-90 recorded after the durability analysis: (a) image indicating the mixed dispersion of the trigonal bipyramidal and truncated cubes on the surface of NGr, (b) higher magnification image of the marked (red) portion of (a) and (c) magnified image of the region marked in the green square in (b) and (d) magnified view of the truncated cube marked in the blue square in (c) with the inset showing the SAED pattern.

